Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,617	SINGH ET AL.	
Examiner	Art Unit	_
Brandon W. Bowers	2825	

	SEARCHED				
Class	Subclass	Date	Examiner		
716	4	9/28/2006	ВВ		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (see attached report)	9/28/2006	ВВ		
IEEE (replicate/replication/duplicate/duplicati on and logic and FPGA)	9/28/2006	BB		
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